

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/576,373	FUJITA ET AL.	
Examiner		Art Unit		Page 1 of 2
PATRICK D. LYNCH		4155		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,273,877 A	09-1966	GELLER RODGER E; et. al.	267/89
*	B	US-3,924,613 A	12-1975	Beck, Armin	601/149
*	C	US-4,203,098 A	05-1980	Muncheryan, Hrand M.	340/575
*	D	US-4,465,158 A	08-1984	Yamazaki et al.	180/271
*	E	US-4,655,505 A	04-1987	Kashiwamura et al.	297/284.6
*	F	US-4,702,522 A	10-1987	Vail et al.	297/452.56
*	G	US-4,712,834 A	12-1987	Warrick, James C.	297/284.2
*	H	US-4,798,414 A	01-1989	Hughes, Vincent	297/284.4
*	I	US-5,065,079 A	11-1991	Ogasawara, Hiromitsu	318/591
*	J	US-5,092,654 A	03-1992	Inaba et al.	297/284.7
*	K	US-5,439,271 A	08-1995	Ryan, Thomas M.	297/452.56
*	L	US-5,816,653 A	10-1998	Benson, Joseph	297/284.4
*	M	US-5,990,795 A	11-1999	Miller, Bernard J.	340/576

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2837436 A1	09-2003	France	BONFILS, XAVIER	B60N 02/54
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine Translation of Japanese Patent Number 09-238776
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No. 10/576,373	Applicant(s)/Patent Under Reexamination FUJITA ET AL.	
		Examiner PATRICK D. LYNCH	Art Unit 4155	Page 2 of 2

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,231,125 B1	05-2001	Maeda et al.	297/452.56
*	B	US-2001/0022458 A1	09-2001	Kuster et al.	297/284.2
*	C	US-6,392,550 B1	05-2002	Najor, Rene A.	340/576
*	D	US-2002/0060493 A1	05-2002	Nishino et al.	297/452.56
*	E	US-2002/0096932 A1	07-2002	Fujita et al.	297/452.56
*	F	US-6,435,618 B1	08-2002	Kawasaki, Seiji	297/452.56
*	G	US-6,616,229 B2	09-2003	Kuster et al.	297/284.9
*	H	US-6,663,177 B2	12-2003	Blanco et al.	297/284.2
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.